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APR 26 2001

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AOJI ISONO ET AL.

FILING DATE

December 13, 2000

GROUP *Ar 2673*  
Not Yet Known

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>DD</i>	4,904,895	02/27/90	Tsukamoto et al.	313	336	
<i>DD</i>	5,066,883	11/19/91	Yoshioka et al.	313	309	
<i>DD</i>	3,569,974	11/29/96	Morikawa et al.	313	310	
<i>DD</i>	5,682,085	10/28/97	Suzuki et al.	315	169.1	

## FOREIGN PATENT DOCUMENTS

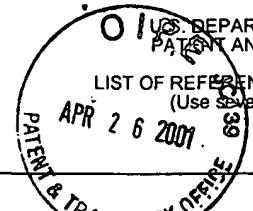
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>DD</i>	JP 3055738	03/11/91	JAPAN	HO1J	001/30	ABSTRACT
<i>DD</i>	JP 4028137	01/30/92	JAPAN	HO1J	001/30	ABSTRACT
<i>DD</i>	JP 2257551	10/18/90	JAPAN	HO1J	031/15	ABSTRACT
<i>DD</i>	JP 1031332	02/01/89	JAPAN	HO1J	001/20	ABSTRACT

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>DD</i>	"Electrical Conduction And Electron Emission of Discontinuous Thin Films", G. Dittmer, Thin Film Solids, 9 (1972), pp. 317-328.
<i>DD</i>	"Electroforming and Electron Emission of Carbon Thin Films", Hisashi Asaki et al., Vacuum, Vol. 26, No. 1, pp. 22-29 (1983).
<i>DD</i>	"Strong Electron Emission From Patterned Tin-Indium Oxide Thin Films", M. Hartwell et al., International Electron Devices Meeting, Washington DC (1975) pp. 519-521.
<i>DD</i>	"The Emission of Hot Electrons and The Field Emission of Electrons From Tin Oxide", M. I. Elinson et al., Radio Engineering and Electronic Physics, July 1965, pp. 1290-1296.

EXAMINER: *Prabodh Dheria*DATE CONSIDERED *11/14/2003*

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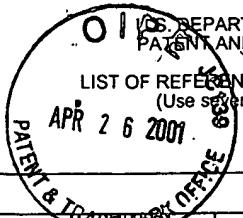
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<i>AB</i>	"Field Emission", W.P. Dyke et al., Advances In Electronics and Electron Physics, (1956), pp. 89-185.
<i>AB</i>	"Physical Properties of Thin-Film Field Emission Cathodes With Molybendum Cones", J. Appl. Phys., 47,5248 (1976), pp. 5248-5263.
<i>AB</i>	"Operation of Tunnel-Emission Devices". C.A.Mead, J. Appl. Phys., vol. 32, Number 4, April1961, pp.646-652

EXAMINER *Prabodh C. Laria*DATE CONSIDERED *11/14/2003*

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	JPA 60-216387	4/12/84	Japan	G09G	3/12	No
	JPA 11-167366	6/22/99	Japan	G09G	3/20	Abstract
	JPA 10-172479	6/26/98	Japan	G09G	3/26	Abstract
	JPA 63-304228	12/12/88	Japan	G02F	3/22	Abstract
	JPA 03048889	1/3/91	Japan	G09G	3/36	Abstract

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EXAMINER *Probodh Dhar*

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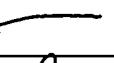
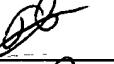
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	JPA	62-206589	9/11/87	Japan	G09G	3/22	No
	JPA	02273720	8/11/90	Japan	G02F	1/133	Abstract
	JPA	4-107293	9/16/92	Japan	G09G	3/12	YES No
	JPA	02272490	7/11/90	Japan	G09G	3/36	Abstract

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